09/38158 532 Rec'd PCT/PTC 09 AUG 2000

Attorney Docket No. IDR0001 Client Matter No. 80654.001

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE UNDER THE PATENT COOPERATION TREATY

In re Application of:

Steven J. SHATTIL

Serial No.

Examiner:

Filed: August 9, 2000

Art Unit:

For:

MULTIPLE ACCESS METHOD

AND SYSTEM

INFORMATION DISCLOSURE STATEMENT

Assistant Commissioner for Patents Washington, D.C. 20231

Dear Sir:

Pursuant to 37 C.F.R. § 1.97, the Examiner may wish to consider the references listed on the attached PTO Form 1449. In submitting these references, no representation is made or implied that the references are or are not material to the examination of this application. The Examiner is encouraged to make his or her own determination of materiality.

Copies of the references are provided.

No fee is believed due with this submittal. However, any fee deficiency associated herewith may be charged to Deposit Account No. 50-1123.

Respectfully submitted,

August 9, 2000

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09/381588 532 Rec'd PCT/FTC 09 AUG 2000

FORM PTO-1449 (Modified)	U.S. DEPARTMENT OF C		ATTY. DOCKET NO. IDR0001		SERIAL NO.			
INFORMATION DISCLOSURE STATEMENT BY APPLICANT			APPLICANT: Steven J. SHATTIL					
(Use several sheets if necessary)			FILING DATE: August 9,	GROUP				
		U.S. PA	TENT DOCUMENTS					
INITIAL	PATENT NO.	ISSUE DATE	PATENTEE	CLASS	SUBCLASS	FILING DA	ATE	
	5,563,906	Oct. 8, 1996	Hershey, et al.					
	5,519,692	May 21, 1996	Hershey, et al.					
	4,628,517	Dec. 9, 1986	Schwarz, et al.					
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				1				
				 				
	FOREIGN PA	TENT OR PUBL	LISHED FOREIGN PATE	INT APPLIC	ATION	1		
	DOC. NO. PUBL. DATE		COUNTRY	CLASS	SUBCLASS	TRANSLATION		
						YES	NO	
				<u> </u>				
OTHER	R DOCUMENTS (Include	ding Author, Tit	le, Date, Pertinent Page	es, Etc.)				
				_				
EXAMINER				DATE CONS	CONSIDERED			
FYAMINED: Initia	l if citation considered wh	ether or not citatia	on is in conformance with I	MDED EUG. D.	w line through	citation if no	nt in	

conformance and not considered. Include copy of this form with next communication to applicant.